

**Search Notes**

Application/Control No.

10/827,128

Examiner

Richard K. Lee

Applicant(s)/Patent under  
Reexamination

HOEHNE ET AL.

Art Unit

2832

**SEARCHED**

Class	Subclass	Date	Examiner
200	520	9/3/2005	KL
	314		
	345		
	16D		
	310		
	341		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST print out	9/3/2005	KL